

UNISONIC TECHNOLOGIES CO., LTD

11N90 Power MOSFET

11 Amps, 900 Volts N-CHANNEL POWER MOSFET

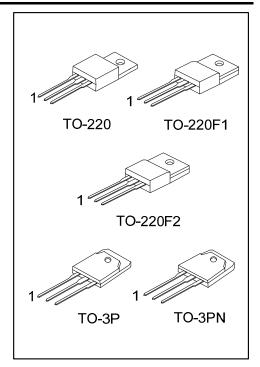
■ DESCRIPTION

The UTC **11N90** is an N-channel enhancement mode Power FET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology specializes in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

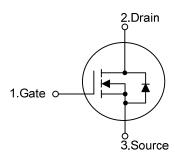
The UTC **11N90** is universally applied in high efficiency switch mode power supply,

■ FEATURES

- * $R_{DS(on)}$ < 1.1 Ω @ V_{GS} = 10V, I_D = 5.5A
- * High switching speed
- * Improved dv/dt capability
- * 100% avalanche tested



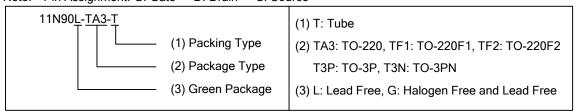
SYMBOL



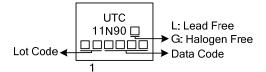
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Doolsing
Lead Free	Halogen Free	Package	1	2 3		Packing
11N90L-TA3-T	11N90G-TA3-T	TO-220	G	D	S	Tube
11N90L-TF1-T	11N90G-TF1-T	TO-220F1	G	D	S	Tube
11N90L-TF2-T	11N90G-TF2-T	TO-220F2	G	D	S	Tube
11N90L-T3P-T	11N90G-T3P-T	TO-3P	G	D	S	Tube
11N90L-T3N-T	11N90G-T3N-T	TO-3PN	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING



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■ ABSOLUTE MAXIMUM RATINGS(T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	900	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous	I _D	11	Α
	Pulsed (Note 1)	I _{DM}	44	Α
Avalanche Energy	Single Pulsed (Note 2)	E _{AS}	1000	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt 4.0		V/ns
Power Dissipation	TO-220		160	W
	TO-220F1/TO-220F2	P _D	50	W
	TO-3P/TO-3PN		215	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55~+150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL CHARACTERISTICS

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-220F1 TO-220F2 θ _{JA}		62.5	°C/W
	TO-3P/TO-3PN		40	°C/W
	TO-220		0.78	°C/W
Junction to Case	TO-220F1/TO-220F2	θ_{JC}	2.48	°C/W
	TO-3P/TO-3PN		0.58	°C/W

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■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise noted)

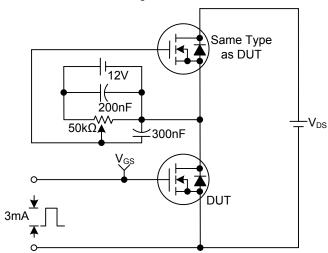
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS				•			
Drain-Source Breakdown Voltage		BV _{DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	900			V
Breakdown Voltage Temperature Coefficient		△BV _{DSS} /△T _J	I _D =250μA, Referenced to 25°C		1.0		V/°C
Drain-Source Leakage Current		I _{DSS}	I_{DSS} $V_{DS}=900V, V_{GS}=0V$ $V_{DS}=720V, T_{C}=125^{\circ}C$			10 100	μA
Gate- Source Leakage Current Reverse		I _{GSS}	V _{GS} =+30V, V _{DS} =0V V _{GS} =-30V, V _{DS} =0V			100 -100	nA nA
ON CHARACTERISTICS	1	l .	7-00,	I			
Gate Threshold Voltage		$V_{GS(TH)}$	V _{DS} =V _{GS} , I _D =250μA	3.0		5.0	V
Static Drain-Source On-State Re	sistance	R _{DS(ON)}	V _{GS} =10V, I _D =5.5A		0.91	1.1	Ω
DYNAMIC PARAMETERS						-	
Input Capacitance		C _{ISS}			980	1380	pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		170	280	pF
Reverse Transfer Capacitance		C _{RSS}			18	25	pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_{G}	V _{GS} =10V, V _{DS} =50V, I _D =1.3A		60	80	nC
Gate to Source Charge		Q_{GS}	(Note 4, 5)		14		nC
Gate to Drain Charge		Q_{GD}	(14010 4, 0)		22		nC
Turn-ON Delay Time		t _{D(ON)}	V_{DD} =30V, I_{D} =0.5A, R_{G} =25 Ω (Note 4, 5)		125	140	ns
Rise Time		t _R			260	320	ns
Turn-OFF Delay Time		t _{D(OFF)}			340	380	ns
Fall-Time		t _F			220	270	ns
SOURCE- DRAIN DIODE RATII	NGS AND	CHARACTERI	STICS				
Maximum Body-Diode Continuous Current		I _S				11	Α
Maximum Body-Diode Pulsed Current (Note1)		I _{SM}				44	Α
Drain-Source Diode Forward Voltage (Note 4)		V _{SD}	I _S =11A, V _{GS} =0V			1.4	V

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature.

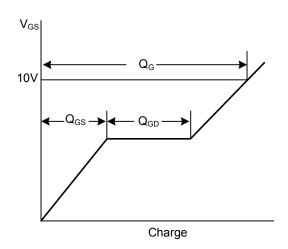
- 2. L = 15mH, I_{AS} = 11A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}C$
- 3. $I_{SD} \le 11.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%
- 5. Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

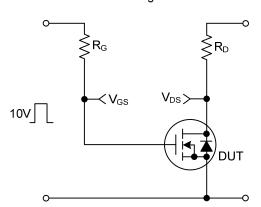
Gate Charge Test Circuit



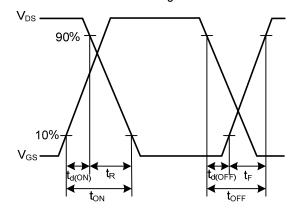
Gate Charge Waveforms



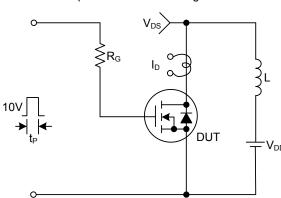
Resistive Switching Test Circuit



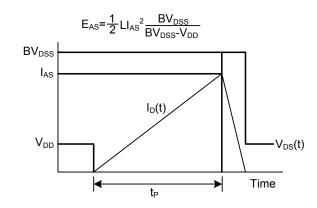
Resistive Switching Waveforms



Unclamped Inductive Switching Test Circuit

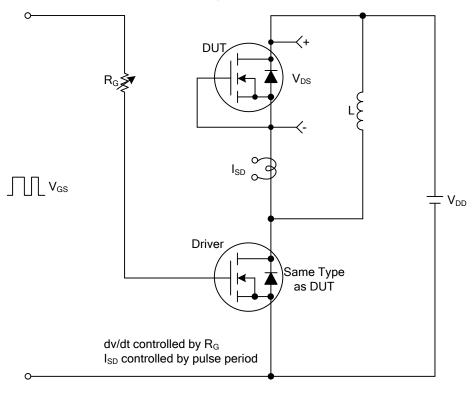


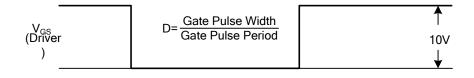
Unclamped Inductive Switching Waveforms

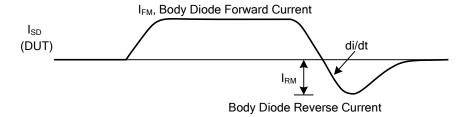


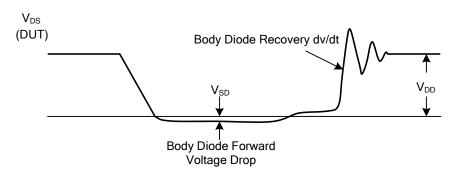
■ TEST CIRCUITS AND WAVEFORMS

Peak Diode Recovery dv/dt Test Circuit & Waveforms

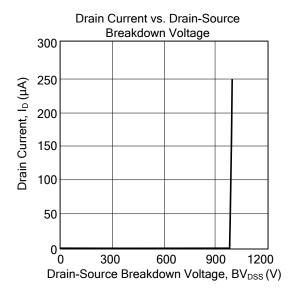


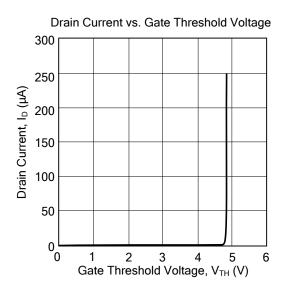


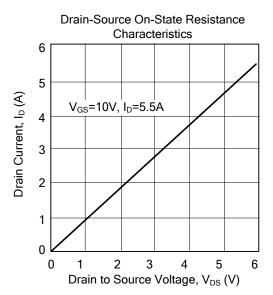


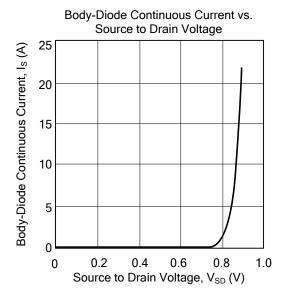


TYPICAL CHARACTERISTICS









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